

# Search Notes



Application/Control No.

10/636,108

Examiner

Sanh D. Phu

Applicant(s)/Patent under Reexamination

INOUE ET AL.

Art Unit

2618

## SEARCHED

Class	Subclass	Date	Examiner
455	130 129 575.7	4/12/06	SP
	82		
	83		
375	261		
	219		
	220		
361	321.3		
343	795	✓	✓

## INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

## SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
EAST SEARCH	4/12/06	SP